



TEST REPORT: IRM-02-24

2W Single Output Encapsulated Type

■ DESIGN VERIFY TEST

Output Function Test

Input Function Test

Protection Function Test

Component Stress Test

■ SAFETY & E.M.C. TEST

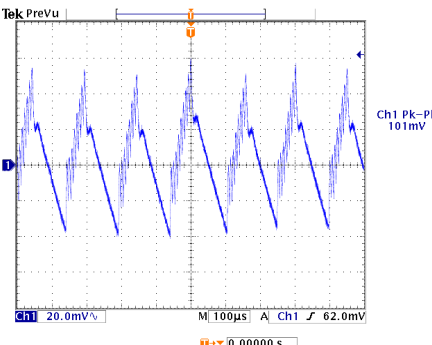
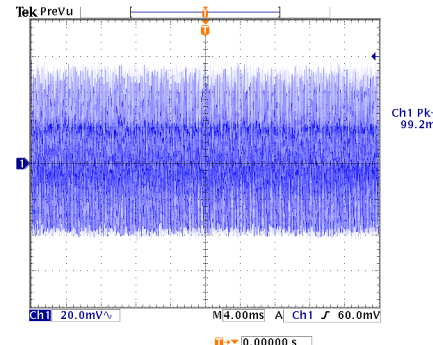
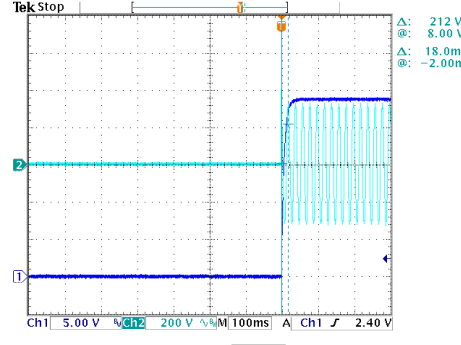
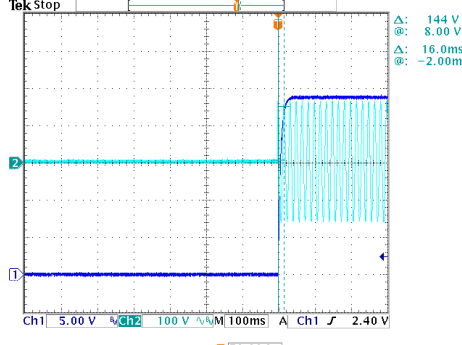
Safety Test

E.M.C. Test

■ RELIABILITY TEST

ENVIRONMENT TEST

DESIGN VERIFY TEST OUTPUT FUNCTION

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	OUTPUT VOLTAGE RANGE	CH1: 23.760V ~ 24.240V	I/P : 230VAC O/P: MIN LOAD TA : 25°C	CH1: 23.89V
2	OUTPUT VOLTAGE TOLERANCE (Max)	V1 : 2.5% ~ -2.5%	I/P : 100VAC / 305VAC O/P: FULL / MINLOAD TA= 25°C	V1: -0.46% ~ -0.50%
3	LINE REGULATION (MAX.)	V1 : 0.5% ~ -0.5%	I/P : 100VAC / 305VAC O/P: FULL LOAD TA: 25°C	V1: 0.00% ~ -0.04%
4	LOAD REGULATION (MAX.)	V1 : 0.5% ~ -0.5%	I/P : 230VAC O/P: MIN LOAD ~ FULL LOAD TA: 25°C	V1: 0.00% ~ 0.00%
5	OVER/UNDERSHOOT TEST	< ±5%	I/P : 230VAC O/P: FULL LOAD TA: 25°C	TEST< 1.24 %
6	RIPPLE & NOISE(Max)	V1 : 200 mVp-p	I/P : 230VAC O/P: FULL LOAD TA: 25°C	V1 : 101 mVp-p
		high frequency : 		
		low frequency : 		
7	SET UP TIME (MAX.)	230VAC : 600ms 115VAC : 600ms	I/P : 230VAC I/P : 115VAC	230VAC : 18ms 115VAC : 16ms
		INPUT=230VAC/50HZ @ FULL LOAD CH1 : Output Voltage CH2 : AC Input Voltage		
				
	RISE TIME (MAX.)	230VAC : 30ms 115VAC : 30ms	I/P : 230VAC I/P : 115VAC O/P: FULL LOAD TA: 25°C	230VAC : 13.8ms 115VAC : 13.8ms
		INPUT=115VAC/60HZ @ FULL LOAD CH1 : Output Voltage CH2 : AC Input Voltage		
				

8	<div> <div> INPUT=230VAC/50HZ @ FULL LOAD CH1 : Output Voltage </div> <div> </div> </div> <div> <div> INPUT=115VAC/60HZ @ FULL LOAD CH1 : Output Voltage </div> <div> </div> </div>
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PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	OVER LOAD PROTECTION	> 110%	I/P: 305VAC I/P: 230VAC I/P: 100VAC O/P: TESTING Ta: 25°C	376% 305VAC 325% 230VAC 240% 100VAC Hiccup Mode
2	OVER VOLTAGE PROTECTION	25.20V ~ 32.40V	I/P: 305VAC I/P: 230VAC I/P: 85VAC O/P: MIN LOAD Ta: 25°C	30.20V 305VAC 30.20V 230VAC 30.20V 85VAC Shut off o/p voltage, clamping by zener diode
3	SHORT PROTECTION	SHORT EVERY OUTPUT 1 HOUR NO DAMAGE	I/P: 305VAC I/P: 85VAC O/P: FULL LOAD Ta: 25°C	NO DAMAGE Hiccup Mode

COMPONENT STRESS TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	PWM Power Transistor	Q1 Rated : 700V 0.4A	I/P : 315VAC VDS : O/P : (1)Full Load Turn on (2) Output Short (3)Full load continue Ta : 25°C	VIN: 315VAC VDS: (1). 634.00V (2). 684.00V (3). 630.00V
2	Input Capacitor	C6 Rated : 5uf 450V	I/P : 315VAC O/P : (1)Full Load Turn on /Off (2)Min load Turn on /Off (3)Full Load /Min load Change Ta : 25°C	(1). 442.00V (2). 446.00V (3). 446.00V
3	Control IC	U1 Rated : 9.00V (max) -0.3V (min)	I/P : 315VAC O/P : (1)Full Load (2)Output Short (3)O.L.P (4)Low Line No Load Vo(min) Ta : 25°C	U1 (1). 6.58V (2). 6.30V (3). 6.30V (4). 6.54V
5	O/P Diode	D100 Rated : 200V 2.0A	I/P : 315VAC O/P : (1)Full Load Turn on (2) Output Short (3)Full load continue Ta : 25°C	(1). 148.00V (2). 123.00V (3). 147.00V
6	Clamp Diode	D1 Rated : 1000V 1.0A	I/P : 315VAC (1)Full load continue Ta : 25°C	(1). 594.00V

SAFETY & E.M.C. TEST
SAFETY TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	WITHSTAND VOLTAGE	I/P-O/P : 3.000KVAC /min	I/P-O/P: 3.300KVAC /min Ta : 25°C	I/P-O/P: 0.05mA NO DAMAGE
2	ISOLATION RESISTANCE	I/P-O/P : 500VDC>100MΩ	I/P-O/P: 500VDC Ta : 25°C/70%RH	I/P-O/P: 9999MΩ NO DAMAGE

E.M.C. TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	HARMONIC	EN61000-3-2 CLASS A	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	PASS
2	CONDUCTION	EN55022 CLASS B	I/P : 230VAC /50HZ O/P : FULL LOAD / 50% LOAD Ta : 25°C	PASS Test by certified Lab
3	RADIATION	EN55022 CLASS B	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	PASS Test by certified Lab
4	E.S.D	EN61000-4-2 INDUSTRY AIR: 8KV / Contact: 4KV	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A
5	E.F.T	EN61000-4-4 INDUSTRY INPUT: 2KV	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A
6	SURGE	IEC61000-4-5 INDUSTRY L-N: 1KV	I/P : 230VAC /50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A

RELIABILITY TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	TEMPERATURE RISE TEST	MODEL : IRM-02-12		
		1. ROOM AMBIENT BURN-IN : 1.0hrs		
		IP: 230VAC O/P: 100% LOAD TA= 18.9℃		
		2. HIGH AMBIENT BURN-IN : 1.0hrs		
		IP: 230VAC O/P: 100% LOAD TA= 73.0℃		
			NO. Position ROOM AMBIENT 18.9℃ HIGH AMBIENT Ta: 73.0℃	
		1 C101 30.1℃ 81.4℃		
		2 T1 33.8℃ 84.4℃		
		3 C6 31.4℃ 81.4℃		
		4 BD1 32.6℃ 82.3℃		
		5 R2 31.0℃ 80.8℃		
		6 L1 31.9℃ 81.6℃		
7 U1 35.9℃ 85.2℃				
8 D100 31.9℃ 83.4℃				
9 D1 33.6℃ 83.2℃				
10 CASE 31.3℃ 81.4℃				
2	OVER LOAD BURN-IN TEST	NO DAMAGE 1 HOUR (MIN)	I/P : 230VAC O/P : 269.46% LOAD Ta : 25℃	TEST : OK
3	LOW TEMPERATURE TURN ON TEST	NO DAMAGE 1 HOUR (MIN)	I/P : 305VAC / 100VAC O/P : FULL LOAD Ta : -30.0℃	TEST : OK
4	HIGH HUMIDITY HIGH TEMPERATURE HIGH VOLTAGE TEST	AFTER 12 HOURS IN CHAMBER ON CONTROL 75℃ NO DAMAGE	I/P : 315VAC O/P : FULL LOAD Ta : 75℃ HUMIDITY= 95.0% RH	TEST : OK
5	TEMPERATURE COEFFICIENT	±0.03% /(0℃~75℃)	I/P : 230VAC O/P : FULL LOAD	±0.0000% /(0℃~75℃)
6	STORAGE TEMPERATURE TEST	1. Thermal shock Temperature : -40℃ ~ +100℃ 2. Temperature change rate : 25℃ / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 5 CYCLE 5. Input/Output condition : STATIC		TEST : OK
7	THERMAL SHOCK TEST	1. Thermal shock Temperature : -35℃ ~ +80℃ 2. Temperature change rate : 25℃ / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 10 CYCLE 5. Input/Output condition : 230VAC Full Load AC ON/OFF test turn on 58sec ; turn off 2sec		TEST : OK



8	VIBRATION TEST	1 Carton & 1 Set (1) Waveform : Sine Wave (2) Frequency : 10~500Hz (4) Acceleration : 5G (5) Test Time : 60 min in each axis (X.Y.Z) (6) Ta : 25°C	TEST : OK
9	CAPACITOR LIFE CYCLE	:SUPPOSE C101 IS THE MOST CRITICAL COMPONENT (1) I/P : 230VAC O/P : FULL LOAD Ta= 25.0°C LIFE TIME (2) I/P : 230VAC O/P : FULL LOAD Ta= 75.0°C LIFE TIME (3) I/P : 230VAC O/P : 75% LOAD Ta= 75.0°C LIFE TIME (4) I/P : 230VAC O/P : 50% LOAD Ta= 75.0°C LIFE TIME	(1). 158118 HRS (2). 56064 HRS (3). 62984.4 HRS (4). 70605.6 HRS
10	MTBF	MIL-HDBK-217F TOTAL FAILURE RATE : 0 KHR	
11	DMTBF /Accelerated Life test	Demonstration Mean Time Between Failure (Expected Life): Above 30000HRS @ TA 75°C	

TEST RESULT	TESTER	REVIEW	APPROVAL
PASS	FRANK	GESG	WANGDZ

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